

IRFB4620PbF

HEXFET® Power MOSFET

Applications

- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

G S

	— .	
V _{DSS}		200V
R _{DS(on)}	typ.	60m Ω
	max.	72.5 m Ω
I _D		25A

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	25	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	18	A
I _{DM}	Pulsed Drain Current ①	100	
P _D @T _C = 25°C	Maximum Power Dissipation	25 18	W
	Linear Derating Factor	0.96	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ③	54	V/ns
T _J	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300	
	(1.6mm from case)		
	Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	

Avalanche Characteristics

E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ②	113	mJ
I _{AR}	Avalanche Current ①	See Fig. 14, 15, 22a, 22b,	Α
E _{AR}	Repetitive Avalanche Energy @		mJ

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		1.045	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑦®		62	

Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.23		V/°C	Reference to 25°C, I _D = 5mA①
R _{DS(on)}	Static Drain-to-Source On-Resistance		60	72.5	mΩ	$V_{GS} = 10V, I_D = 15A $ ④
V _{GS(th)}	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = V_{GS}$, $I_D = 100\mu A$
I _{DSS}	Drain-to-Source Leakage Current			20		$V_{DS} = 200V, V_{GS} = 0V$
				250	μΑ	$V_{DS} = 200V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nΛ	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V
R _{G(int)}	Internal Gate Resistance		2.6		Ω	

Dynamic @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	37			S	$V_{DS} = 50V, I_{D} = 15A$
Q_g	Total Gate Charge		25	38		I _D = 15A
Q_{gs}	Gate-to-Source Charge		8.2		nC	$V_{DS} = 100V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		7.9		iiC	V _{GS} = 10V ④
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		17			$I_D = 15A, V_{DS} = 0V, V_{GS} = 10V$
t _{d(on)}	Turn-On Delay Time		13.4			$V_{DD} = 130V$
t _r	Rise Time		22.4		no	I _D = 15A
$t_{d(off)}$	Turn-Off Delay Time		25.4		ns	$R_G = 7.3\Omega$
t _f	Fall Time		14.8			V _{GS} = 10V ④
C _{iss}	Input Capacitance		1710			$V_{GS} = 0V$
C _{oss}	Output Capacitance		125			$V_{DS} = 50V$
C _{rss}	Reverse Transfer Capacitance		30		рF	f = 1.0MHz (See Fig.5)
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)®		113			$V_{GS} = 0V$, $V_{DS} = 0V$ to 160V $(See Fig.11)$
	Effective Output Capacitance (Time Related)®		317			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 160V $

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			25		MOSFET symbol
	(Body Diode)			25	Α	showing the
I _{SM}	Pulsed Source Current			100	_ A	integral reverse
	(Body Diode) ①			100		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	٧	$T_J = 25^{\circ}C, I_S = 15A, V_{GS} = 0V $
t _{rr}	Reverse Recovery Time		78			$T_J = 25^{\circ}C$ $V_R = 100V$,
			99			$T_J = 125^{\circ}C$ $I_F = 15A$
Q _{rr}	Reverse Recovery Charge		294			$T_J = 25^{\circ}C$ di/dt = 100A/ μ s @
			432			$T_J = 125^{\circ}C$
I _{RRM}	Reverse Recovery Current		7.6		Α	$T_J = 25^{\circ}C$
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax} , starting T_J = 25°C, L = 1.0mH R_G = 25 Ω , I_{AS} = 15A, V_{GS} =10V. Part not recommended for use above this value .
- $\label{eq:loss_def} \mbox{ } \mbox{ } \mbox{I}_{SD} \leq \mbox{15A}, \mbox{ } \mbox{di/dt} \leq \mbox{634A/\mu s}, \mbox{ } \mbox{V}_{DD} \leq \mbox{V}_{(BR)DSS}, \mbox{ } \mbox{T}_{J} \leq \mbox{175}^{\circ}\mbox{C}.$
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.

- $\ ^{\circ}$ C $_{oss}$ eff. (TR) is a fixed capacitance that gives the same charging time as C $_{oss}$ while V $_{DS}$ is rising from 0 to 80% V $_{DSS}.$
- $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \$ $\$ $\ \$ $\ \$ $\$
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

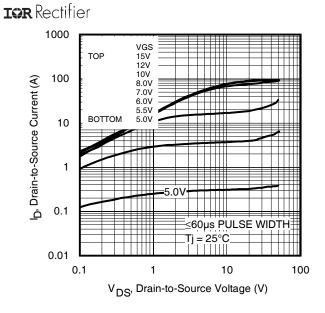


Fig 1. Typical Output Characteristics

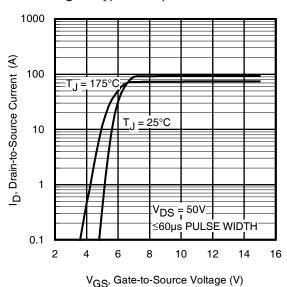


Fig 3. Typical Transfer Characteristics

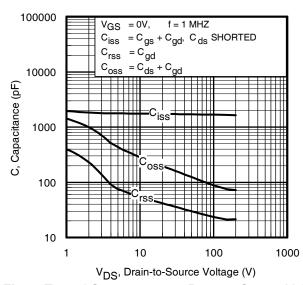


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage www.irf.com

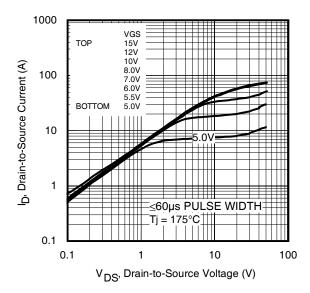


Fig 2. Typical Output Characteristics

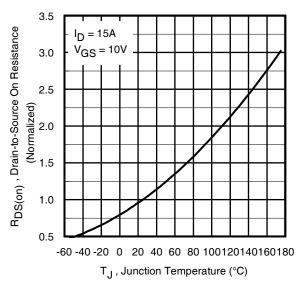


Fig 4. Normalized On-Resistance vs. Temperature

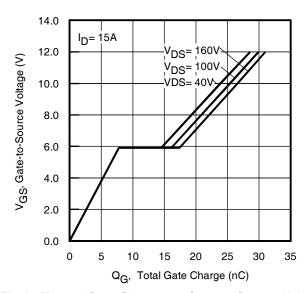


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

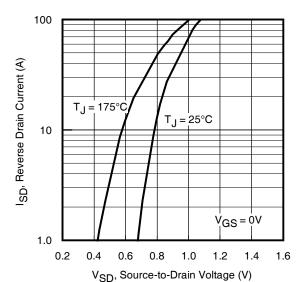
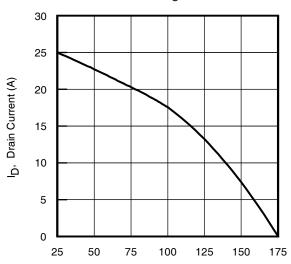
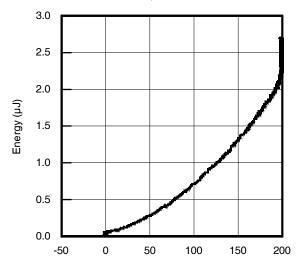


Fig 7. Typical Source-Drain Diode Forward Voltage



T_C, Case Temperature (°C) **Fig 9.** Maximum Drain Current vs.

Case Temperature



 $\label{eq:VDS} \text{V}_{DS,} \text{ Drain-to-Source Voltage (V)} \\ \textbf{Fig 11.} \ \, \textbf{Typical C}_{OSS} \ \, \textbf{Stored Energy} \\$

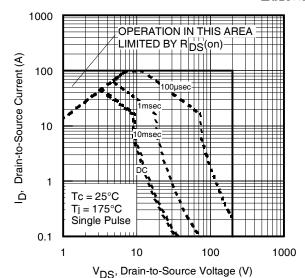


Fig 8. Maximum Safe Operating Area

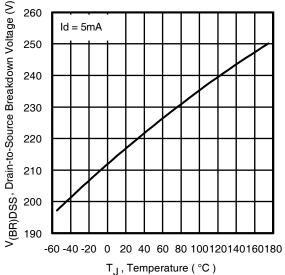


Fig 10. Drain-to-Source Breakdown Voltage

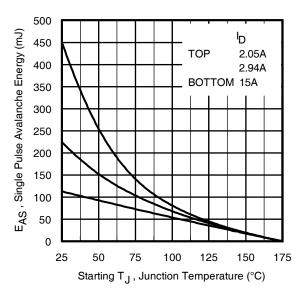


Fig 12. Maximum Avalanche Energy vs. DrainCurrent www.irf.com

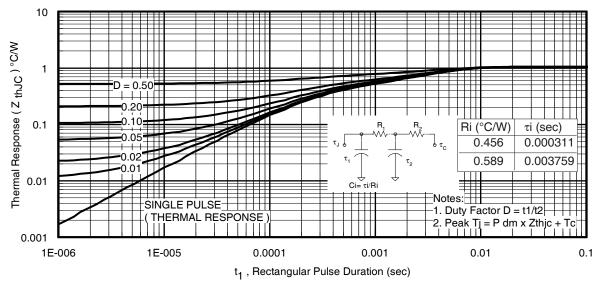


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

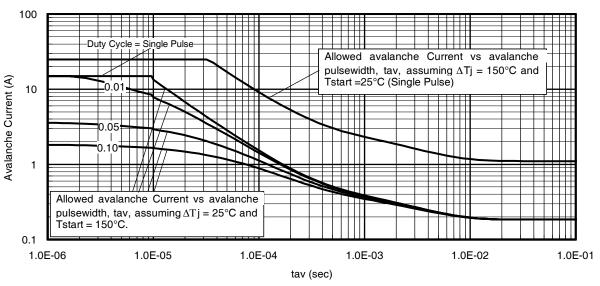


Fig 14. Typical Avalanche Current vs. Pulsewidth

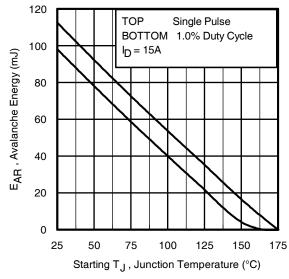


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.

- 2. Safe operation in Avalanche is allowed as long asT_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

t_{av =} Average time in avalanche.

 $D = Duty cycle in avalanche = t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} = \triangle \text{T/ } Z_{thJC} \\ I_{av} &= 2\triangle \text{T/ [} 1.3 \cdot \text{BV} \cdot Z_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

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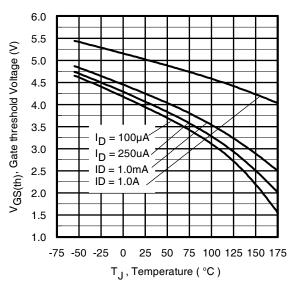


Fig 16. Threshold Voltage vs. Temperature

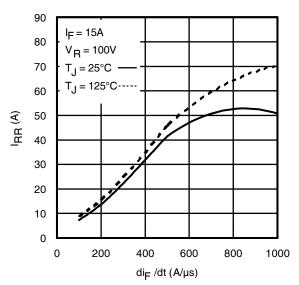


Fig. 18 - Typical Recovery Current vs. dif/dt

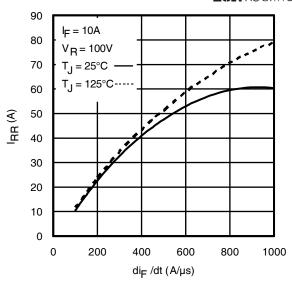


Fig. 17 - Typical Recovery Current vs. di_f/dt

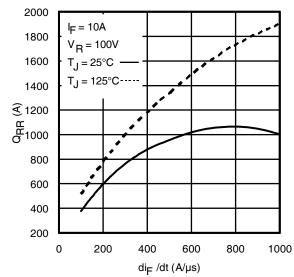


Fig. 19 - Typical Stored Charge vs. dif/dt

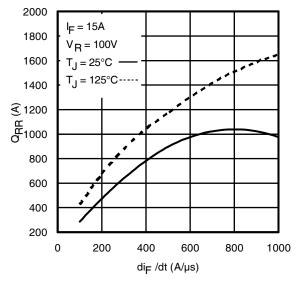


Fig. 20 - Typical Stored Charge vs. di_f/dt

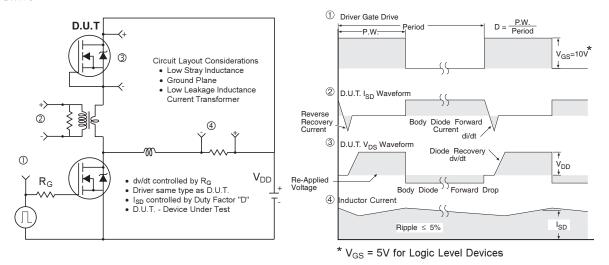


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

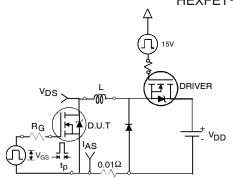


Fig 22a. Unclamped Inductive Test Circuit

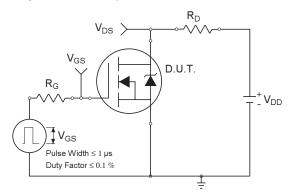


Fig 23a. Switching Time Test Circuit

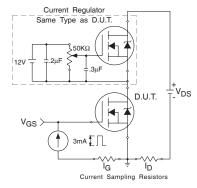


Fig 24a. Gate Charge Test Circuit www.irf.com

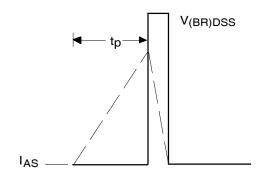


Fig 22b. Unclamped Inductive Waveforms

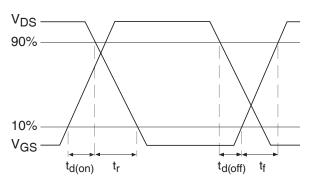


Fig 23b. Switching Time Waveforms

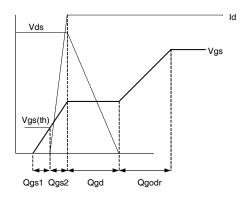
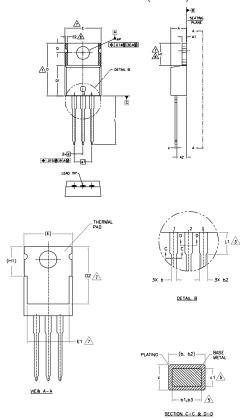


Fig 24b. Gate Charge Waveform

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



- SI MICHISONNIC AND TOLERANCH AS PEP ASILE YI 4.5 W 1994, DMENSONS ARE SHOWN IN INCHES [MILLINETERS], LEAD DIMENSON, A HID FINESY INCONTROLLED IN LI DMENSON, D. 18 & DO NOT INCLUDE MODE TASH, MOLD FLASH SHALL NOT EXCEED AGDS (01.27) PER SIDE, THESE DMENSONS ARE SHALL NOT EXCEED AGDS (01.27) PER SIDE, THESE DMENSONS CAPY, DMENSON of, D. & C. I APPLY TO BASE METAL ONLY. CONTROLLING DMENSON I: NOSES THERMAN, PAD CONTROL OF TORNIAL WITHIN DMENSONS E-HLD2 & ET DMENSON C. 2 NOT DEFINE A ZODE WHERE STAMPHON AND SHOULANDN INFOCULARIES ARE ALLONGO.

SYMBOL	MILLIM	ETERS	INC		
	MIN.	MAX.	MIN.	MAX.	NOTES
A	3,56	4.83	,140	.190	
A1	0,51	1,40	.020	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
ь1	0.38	0.97	.015	.038	5
ь2	1,14	1.78	.045	.070	
b3	1,14	1.73	.045	.068	5
С	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
Ε	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	-	.030	8
e	2.54	BSC	.100		
e1	5.08	BSC	.200	BSC	
H1	5.84 6.86		.230	.270	7,8
L	12.70	14,73	.500	.580	
Lf	3.56	4.06	.140	.160	3
øP	3,54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

OBTs, CoPACK

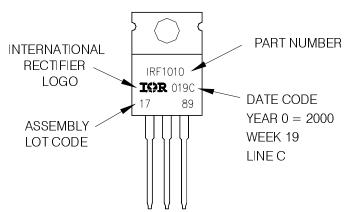
TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789

ASSEMBLED ON WW 19, 2000 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free"



TO-220AB packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Data and specifications subject to change without notice. This product has been designed and qualified for the Industrial market. Qualification Standards can be found on IR's Web site.



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